MOSFET - Single N-Channel 40 V, 2.1 m Ω , 150 A

NTTFS2D1N04HL

Features

- Max $R_{DS(on)} = 2.1 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 23 \text{ A}$
- Max $R_{DS(on)} = 3.3 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 18 \text{ A}$
- High Performance Technology for Extremely Low RDS(on)
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- DC–DC Buck Converters
- Point of Load
- High Efficiency Load Switch and Low Side Switching
- Oring FET

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parar	Parameter			Value	Unit
Drain-to-Source Voltage		V _{DSS}	40	V	
Gate-to-Source Voltage		V _{GS}	±20	V	
Continuous Drain Current $R_{\theta JC}$ (Note 1)	Steady	$T_{C} = 25^{\circ}C$	۱ _D	150	A
Power Dissipation $R_{\theta JC}$ (Note 1)	State		P _D	83	W
Continuous Drain Current $R_{\theta JA}$ (Notes 1, 2)	Steady State	T _A = 25°C	ID	24	A
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)	Olale		P _D	2.2	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I _{DM}	958	А
Operating Junction and Storage Temperature Range		T _J , T _{stg}	– 55 to +150	°C	
Source Current (Body Diode)		۱ _S	69	А	
Single Pulse Drain-to-Source Avalanche Energy (I _{AV} = 29 A, L = 0.3 mH) (Note 3)		E _{AS}	126	mJ	
Lead Temperature Soldering Reflow for Sol- dering Purposes (1/8" from case for 10 s)		ΤL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 1)	$R_{\theta JC}$	1.5	°C/W
Junction-to-Ambient - Steady State (Note 1)	R _{0.IA}	54.8	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using 1 in² pad size, 1 oz. Cu pad.

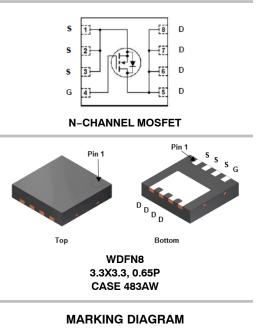
3. E_{AS} of 126 mJ is based on started T_J = 25°C, I_{AS} = 29 A, V_{DD} = 32 V, V_{GS} = 10 V. 100% test at I_{AS} = 29 A.

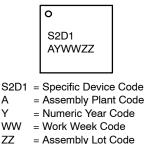


ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	2.1 mΩ @ 10 V	150 A
	$3.3~\mathrm{m}\Omega$ @ $4.5~\mathrm{V}$	150 A





ORDERING INFORMATION

Device	Package	Shipping†
NTTFS2D1N04HLTWG	PQFN8 (Pb-Free)	3000 / Tape & Reel

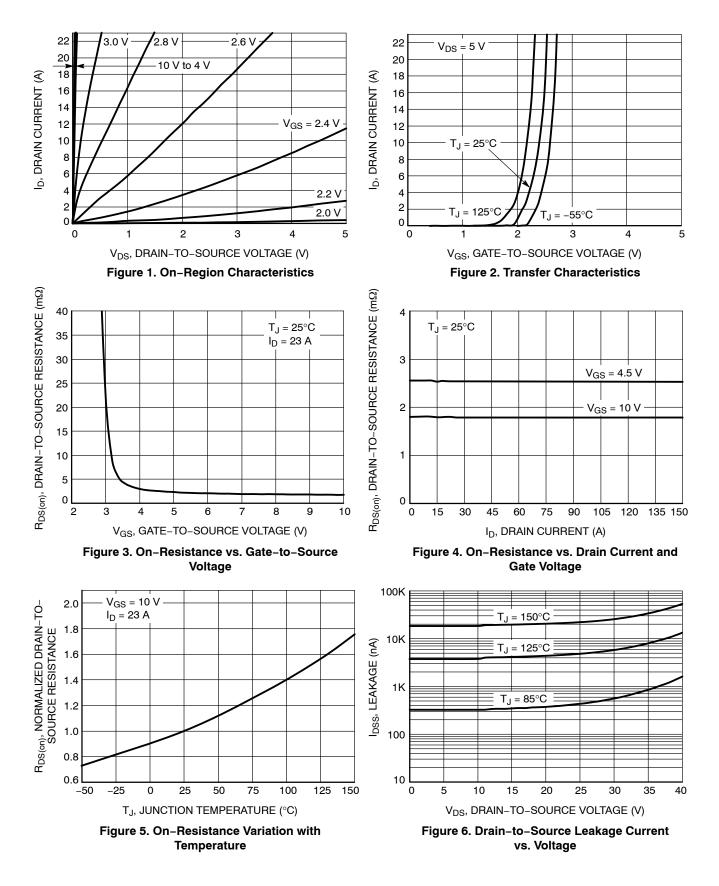
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

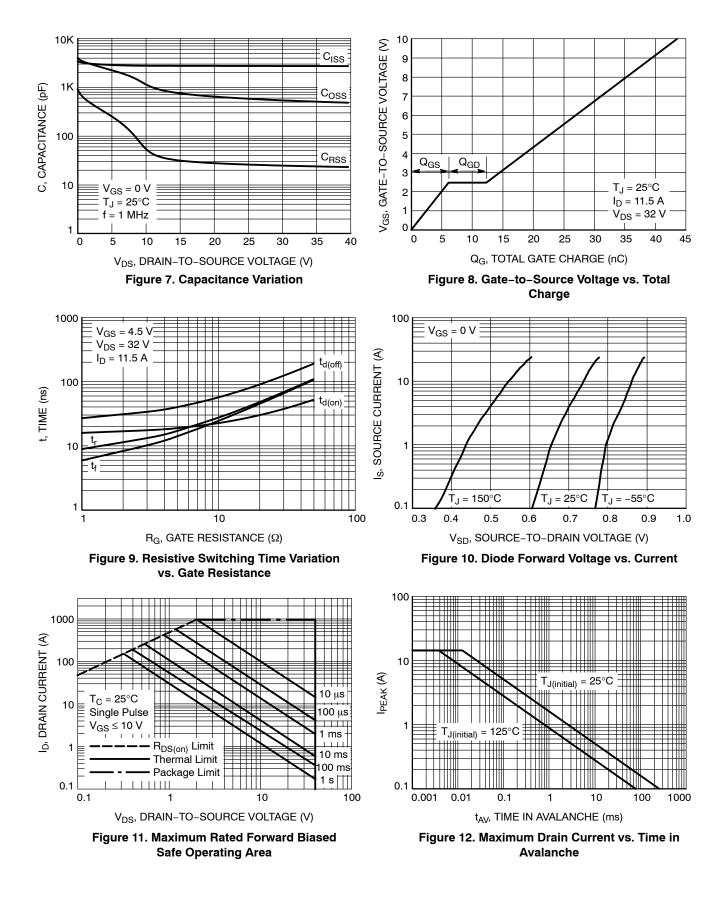
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 µA		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J	$I_D = 250 \ \mu A$, ref to $25^{\circ}C$			21.80		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$ $T_{J} = 25^{\circ}C$				10	μΑ
		V _{DS} = 40 V	T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS}	= 20 V			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D =	= 120 μA	1.2		2.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 120 μA, ref	to 25°C		-4.63		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D	= 23 A		1.7	2.1	mΩ
		V _{GS} = 4.5 V, I _D = 18 A			2.5	3.3	
Forward Transconductance	9 _{FS}	V_{DS} = 15 V, I _D	= 23 A		256		S
Gate-Resistance	R _G	T _A = 25°	С		1		Ω
CHARGES & CAPACITANCES						-	-
Input Capacitance	C _{ISS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 20 V			2745		pF
Output Capacitance	C _{OSS}				645		
Reverse Transfer Capacitance	C _{RSS}				38		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 32 V, I_{D} = 11.5 A			43.6		nC
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 4.5 V, V_{DS} = 32	V, I _D = 11.5 A		20.7		nC
Gate-to-Source Charge	Q _{GS}				6.1		
Gate-to-Drain Charge	Q _{GD}				6.2]
Plateau Voltage	V _{GP}				2.5		V
SWITCHING CHARACTERISTICS (Note	4)						
Turn-On Delay Time	t _{d(ON)}	V _{GS} = 4.5 V, V _{DI}	$_{0} = 32 V,$		17		ns
Rise Time	tr	I _D = 11.5 A, R _G = 2.5 Ω			12]
Turn-Off Delay Time	t _{d(OFF)}				32		
Fall Time	t _f				9		
DRAIN-SOURCE DIODE CHARACTERIS	STICS					-	-
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$		0.79	1.2	V
		I _S = 23 A	T _J = 125°C		0.64		1
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dI _S /dt = 100 A/µs, I _S = 11.5 A			22		ns
Reverse Recovery Charge	Q _{RR}				17		nC
Charge Time	t _a	$\label{eq:VGS} \begin{array}{l} V_{GS} = 0 \text{ V, } dI_S/dt = 100 \text{ A}/\mu\text{s}, \\ I_S = 11.5 \text{ A} \end{array}$			22		ns
Discharge Time	t _b				13		ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product Product parametric performance is indicated in the Electrical Characteristics if operated under different conditions.
Switching characteristics are independent of operating junction temperatures
As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

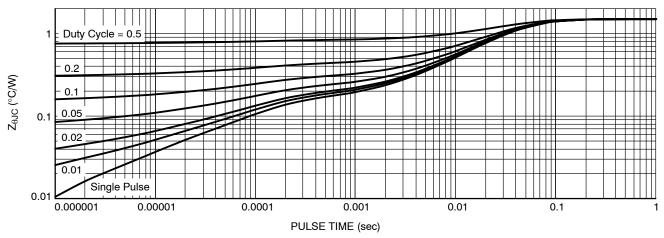


Figure 13. Transient Thermal Impedance

1. CONTROLLING DIMENSION: MILLIMETERS.

2. COPLANARITY APPLIES TO THE EXPOSED

3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.

DISTANCE FROM THE SEATING PLANE TO THE

MILLIMETERS

NOM

0.75

-

0.32

0.20

3.30

2.27 REF

0.52 REF

3.30

1.95

0.65 BSC

1.95 BSC

0.33 REF

0.40

0.34 REF

0.10

0.10

0.10

0.05

0.05

LOWEST POINT ON THE PACKAGE BODY.

MIN

0.70

-

0.27

0.15

3.20

3.20

1.85

0.30

PADS AS WELL AS THE TERMINALS.

4. SEATING PLANE IS DEFINED BY THE TERMINALS. 'A1' IS DEFINED AS THE

DIM

A

A1

b

С

D

D1

D2

Е

E1

е

e1

k

L

L1

aaa bbb

ccc

ddd

eee





WDFN8 3.3X3.3, 0.65P CASE 483AW **ISSUE A**

NOTES:

DATE 10 SEP 2019

MAX

0.80

0.05

0.37

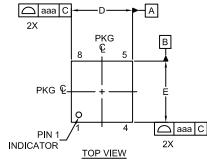
0.25

3.40

3.40

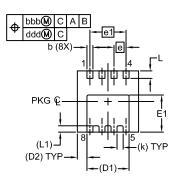
2.05

0.50

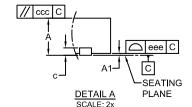


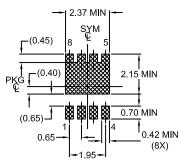


FRONT VIEW



BOTTOM VIEW





*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

GENERIC **MARKING DIAGRAM***



XXXX = Specific Device Code

- = Assembly Location А
- = Year Υ
- WW = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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